

#### ES51C1 A 10 V -20.000M TR



Operating Temperature Range 0°C to +50°C

Packaging Options Tape & Reel

Nominal Frequency 20 000MHz

Control Voltage 1.5Vdc ±1.0Vdc

Frequency Stability -±1.0ppm Maximum

#### **ELECTRICAL SPECIFICATIONS** Nominal Frequency 20.000MHz Frequency Stability vs. Frequency ±1.0ppm Maximum (Measured at 25°C ±2°C, Vdd=5.0Vdc, Vc=1.5Vdc) Tolerance **Frequency Stability** ±1.0ppm Maximum Frequency Stability vs. Input Voltage ±0.2ppm Maximum (Vdd ±5%) Frequency Stability vs. Aging ±1ppm/Year Maximum (at 25°C) Frequency Stability vs. Load ±0.2ppm Maximum (±1kOhm//±1pF) 0°C to +50°C **Operating Temperature Range** Supply Voltage 5.0Vdc ±5% 2.0mA Maximum Input Current **Output Voltage** 0.8Vp-p Clipped Sinewave Minimum Load Drive Capability 10kOhms//10pF **Output Logic Type Clipped Sinewave Control Voltage** 1.5Vdc ±1.0Vdc **Frequency Deviation** ±8ppm Minimum Linearity 10% Maximum **Transfer Function** Positive Transfer Characteristic **Modulation Bandwidth** 3kHz Minimum (Measured at -3dB with a Control Voltage of 1.5Vdc) Input Impedance 100kOhms Minimum

**Phase Noise** -80dBc/Hz at 10Hz offset, -115dBc/Hz at 100Hz offset, -135dBc/Hz at 1kHz offset, -145dBc/Hz at 10kHz offset, -145dBc/Hz at 100kHz offset (Typical Values, at 12.800MHz) Start Up Time 5mSec Maximum

**ENVIRONMENTAL & MECHANICAL SPECIFICATIONS** 

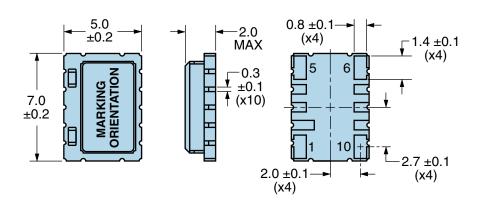
-55°C to +125°C

Storage Temperature Range

Fine Leak Test	MIL-STD-883, Method 1014 Condition A	
Gross Leak Test	MIL-STD-883, Method 1014 Condition C	
Mechanical Shock	MIL-STD-202, Method 213 Condition C	
Resistance to Soldering Heat	MIL-STD-202, Method 210	
Resistance to Solvents	MIL-STD-202, Method 215	
Solderability	MIL-STD-883, Method 2003	
Temperature Cycling	MIL-STD-883, Method 1010	
Vibration	MIL-STD-883, Method 2007 Condition A	



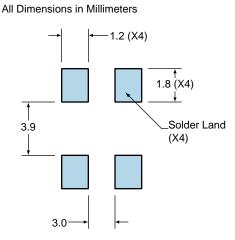
### **MECHANICAL DIMENSIONS (all dimensions in millimeters)**



PIN	CONNECTION
1	Voltage Control
2	Do Not Connect
3	Do Not Connect
4	Do Not Connect
5	Case/Ground
6	Output
7	Do Not Connect
8	Do Not Connect
9	Do Not Connect
10	Supply Voltage
LINE	MARKING
1	<b>E20.000</b> <i>E=Ecliptek</i>
2	XXYZZ XX=Ecliptek Manufacturing Code Y=Last Digit of the Year

ZZ=Week of the Year

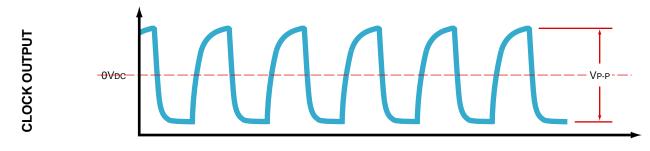
#### Suggested Solder Pad Layout



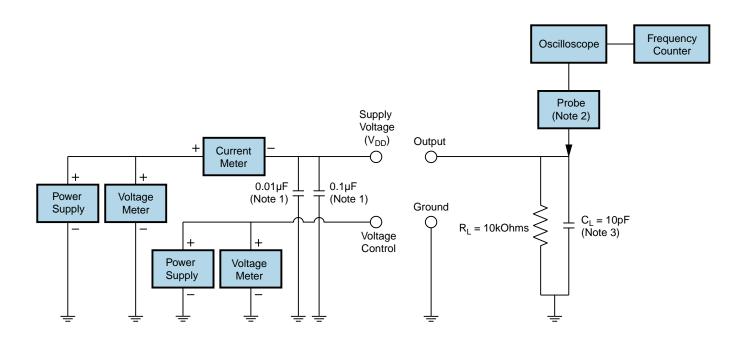
All Tolerances are ±0.1



#### OUTPUT WAVEFORM



#### **Test Circuit for Voltage Control Option**



Note 1: An external 0.1µF low frequency tantalum bypass capacitor in parallel with a 0.01µF high frequency ceramic bypass capacitor close to the package ground and V<sub>DD</sub> pin is required.

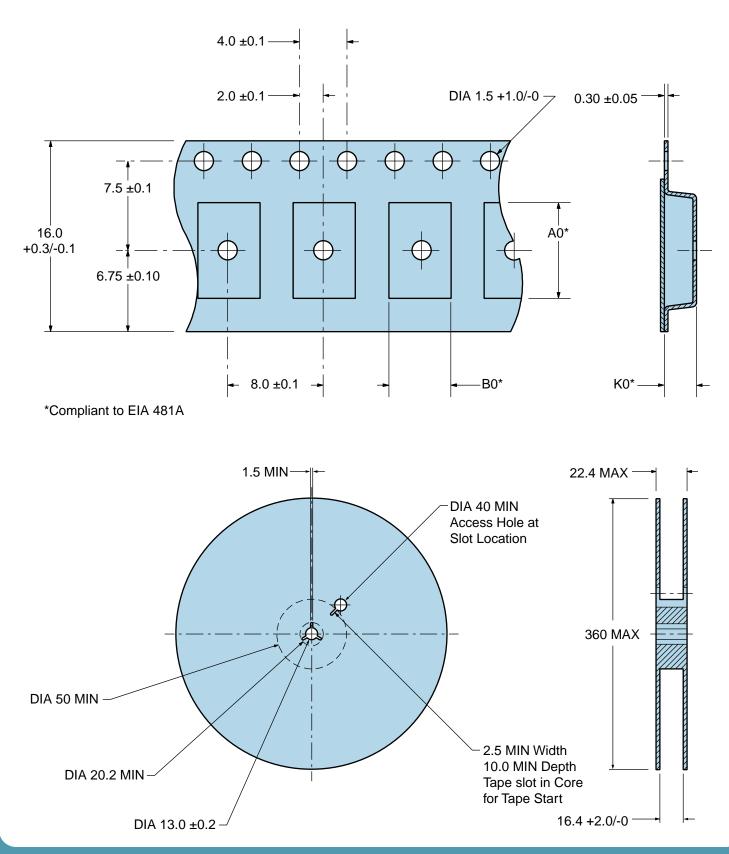
Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value  $C_L$  includes sum of all probe and fixture capacitance.



### **Tape & Reel Dimensions**

Quantity Per Reel: 1,000 units



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### **Recommended Solder Reflow Methods**

ES51C1A10V-20.000M TR



### Low Temperature Infrared/Convection 220°C

T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate)	5°C/second Maximum
Preheat	
- Temperature Minimum (T <sub>s</sub> MIN)	N/A
- Temperature Typical (T <sub>s</sub> TYP)	150°C
- Temperature Maximum (T <sub>s</sub> MAX)	N/A
- Time (t <sub>s</sub> MIN)	60 - 120 Seconds
Ramp-up Rate (T⊾ to T <sub>P</sub> )	5°C/second Maximum
Time Maintained Above:	
- Temperature (T∟)	150°C
- Time (t∟)	200 Seconds Maximum
Peak Temperature (T <sub>P</sub> )	220°C Maximum
Target Peak Temperature (T <sub>P</sub> Target)	220°C Maximum 1 Time / 215°C Maximum 1 Time
Time within 5°C of actual peak (t <sub>p</sub> )	15 seconds Maximum 1 Time / 80 seconds Maximum 1 Time
Ramp-down Rate	5°C/second Maximum
Time 25°C to Peak Temperature (t)	N/A
Moisture Sensitivity Level	Level 1

#### Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

#### **High Temperature Manual Soldering**

260°C Maximum for 5 seconds Maximum, 2 times Maximum.